

Notice of References Cited	Application/Control No. 10/099,927	Applicant(s)/Patent Under Reexamination KELBERLAU ET AL.	
	Examiner Stephen D. Meier	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6441445	08-2002	Leonardi et al	---
	B	US-6376891	04-2002	Nagatani et al	---
	C	US-6037631	03-2000	Deboy et al	---
	D	US-5994189	11-1999	Akiyama	---
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO-00/36654	12-1999	PCT	Stoisiek	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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